

**Notice of References Cited**

Application/Control No.

09/682,785

Applicant(s)/Patent Under  
Reexamination  
YESTER ET AL.

Examiner

Thu V Nguyen

Art Unit

3661

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	C	US-6,198,996	03-2001	Berstis, Viktors	701/36
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	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	Chene et al (US 2002/0096572 A1)
	V	Liu et al (US 2002/0081985 A1)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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